

Search Notes

Application/Control No.

09/664,329

Examiner

Benny Q. Tieu

Applicant(s)/Patent under
Reexamination

CHAPMAN ET AL.

Art Unit

2642

SEARCHED

Class	Subclass	Date	Examiner
Updated	Search	4/25/2005	BQT
379	201.02-		
	201.04		
	207.02		
455	454 433		
	456.1		
	426.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
379	201.02 219	4/27/2005	BQT
455	426.2		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/25/2005	BQT